MEASUREMENT OF THE APS STORAGE RING ELECTRON BEAM ENERGY SPREAD USING UNDULATOR SPECTRA

B. X. Yang and J. J. Xu†
Advanced Photon Source, Argonne National Laboratory, Argonne, IL

Abstract
The angle-integrated flux spectrum of an undulator has sharp dropoffs at harmonic photon energies. Its derivative therefore shows pronounced peaks with rms width $\Delta \omega/\omega \sim 0.4/nN$, where $\omega$ is the photon energy, $n$ is the harmonic number, and $N$ is the number of undulator periods. For the fundamental photon energy of the Advanced Photon Source diagnostics undulator, the derivative of the angle-integrated flux spectrum is a peak with rms width of ~0.2%. By using this feature, we have successfully developed techniques to measure the energy centroid, spread, and momentum compaction factor of the APS storage ring beam. In this paper, we present analytical and numerical analyses of the undulator spectrum derivative and examine the sources of experimental errors of this technique.

1 INTRODUCTION
Non-invasive measurements of the beam energy and rms energy spread are essential for the study of electron longitudinal beam dynamics. In storage rings, the size of a full damped beam is given by the following

$$\sigma_{x}^{2} = \beta_{x} \varepsilon_{x} + (\sigma_{\eta})^{2},$$

where $\beta_{x}$ is the beta function, $\sigma_{\eta}$ is the dispersion function at the source point, $\varepsilon_{x}$ is the horizontal emittance, and $\sigma_{\eta} = \sigma_{\eta}/\varepsilon_{x}$, the relative rms energy spread of the beam [1]. The beam energy measurements are normally performed with simultaneous measurements of beam sizes at high and low dispersive locations of the magnetic lattice. The accuracy of the beam energy measurements is often limited by that of the lattice parameters, $\beta_{x}$, $\sigma_{\eta}$, which are difficult to measure with high accuracy.

In 1996, Tarazona and Elleaume used undulator radiation spectra to derive electron beam energy and emittance by fitting the experimental spectra to a straightforward theoretical model [2]. In that work, the dispersion function at the source was no longer required. But a good knowledge of the beta function was still needed.

In this work, we propose a new measurement using the undulator radiation that employs a different part of the undulator spectrum (measuring the angle-integrated spectrum in a narrow energy span near undulator harmonics) and a different procedure for data treatment (compare the derivative of the spectrum with the model calculation).

We introduce the basics of the technique and discuss analytical expressions in Section 2. In Section 3, we propose experimental schemes to measure the electron beam energy spread and absolute energy. Sources of experimental errors and possible single-bunch single-pass measurement are also discussed.

2 BASIC FORMULAE

2.1 Angular Distribution of Undulator Radiation
The angular distribution of undulator radiation (within a spectral width $\Delta \omega$) is given by the following [3],

$$\frac{dF_{x}\omega}{d\Omega} = \alpha \frac{\Delta \omega}{\omega} I \left( \frac{\gamma Np}{2} \right)^{2} \left| S_{\omega} (\omega, \theta) \right| B^{2}_{\omega},$$

(2)

where $\alpha$ is the fine structure constant, $\omega$ the photon frequency, $K$ the undulator parameter, $N$ the number of undulator periods, $E = \gamma mc^{2}$ the energy of the electron, and $(\theta, \phi)$ are polar angles. The superscript (0) means that the expression is for electron beams with zero emittance and zero energy spread. The fundamental resonance photon energy is

$$\omega_{r}(\gamma, \theta) = \frac{2\pi}{\lambda_{u}} + \frac{2\gamma^{2}}{\lambda_{u} + K^{2} + \gamma^{2}},$$

where $\lambda_{u}$ is the undulator period length. The functions $S_{\omega}$ and $B_{\omega}$ are given by

$$S_{\omega} = \left[ \sin \frac{N\gamma \omega}{\omega_{r}(\gamma, \theta)}/N \right] \left[ \frac{\pi \omega}{\omega_{r}(\gamma, \theta)} \right]^{2},$$

and

$$B_{\omega} = \frac{1}{\pi} \int_{-\infty}^{\infty} \left( \frac{\gamma \theta \cos \phi}{K} - \cos \xi \right) \left( \frac{\omega_{r}(\gamma, \theta) \cos \phi \sin \xi + \sin \xi}{\xi e^{i\gamma \theta \cos \phi \sin \xi + \sin \xi}} \right) d\xi,$$

(5)

where $p = 2$, $\omega = \omega_{r}(\gamma, \theta)/1 + K^{2}/2$, and $q = 1$. Then we can calculate $\omega_{r}(\gamma, \theta)$.

2.2 Angle-Integrated Spectrum of Undulator Radiation for Mono-Energetic Electron Beam
Integrating over all angles, we obtain the angle-integrated spectrum

$$F_{x}\omega(\gamma, \theta) = \frac{\alpha N^{2} \gamma^{2} p}{4} I \frac{\Delta \omega}{\omega} \left[ S_{\omega} (\omega, \theta) \sin \theta d\theta \right]^{2} B_{\omega} |d\phi|.$$}

(6)

Let us define a dimensionless frequency $\nu$ and a new angle variable $\mu$.

$$\nu = \frac{\omega}{\omega_{r}(\gamma, \theta)}, \quad \mu = \frac{\omega}{\omega_{r}(\gamma, \theta)} = \nu \left( 1 + \frac{\gamma^{2} \theta^{2}}{1 + K^{2}/2} \right).$$

(7)

We have

$$S_{\omega} = S_{\nu}(\mu) = \left[ \frac{\sin N\mu \pi}{N \sin \mu \pi} \right]^{2},$$

(8)
and

\[ F_{\pi,\sigma}^{(0)} = \frac{\alpha N^2}{2} \frac{\Delta \omega}{\omega_0(\gamma,0)} \frac{1}{e + \frac{K^2}{2} \nu} \int_{0}^{\infty} S_n(\mu) d\mu B_{\pi,\sigma}^2 d\phi. \] (9)

where we have used the exact expression \( \mu(\theta = 0) = \nu \) and the approximation \( \mu(\theta = \pi) \to \infty \). For this work, we are very interested in the scaled derivative of the total flux spectrum, defined as

\[ D_{\pi,\sigma}^{(0)}(\gamma,\nu) \equiv -\nu \frac{dF_{\pi,\sigma}^{(0)}}{d\nu}. \] (10)

Because \( \mu \) is a dummy variable in the integration and is independent of \( \nu \), we can write the total angle-integrated radiation spectrum for photons of both polarizations,

\[ D^{(0)}(\gamma,\nu) = D_{\pi}^{(0)}(\gamma,\nu) + D_{\sigma}^{(0)}(\gamma,\nu), \]

\[ = \sin^2 \frac{\nu \pi}{2} H^{(0)}(\gamma,\nu) S_n(\nu) + C^{(0)}(\gamma,\nu) \]

where

\[ H^{(0)}(\gamma,\nu) = 4\pi \alpha N^2 \frac{\Delta \omega}{\omega_0(\gamma,0)} \frac{1}{e + \frac{K^2}{2} \nu} \left[ \frac{J_{\pi,\sigma}(\nu) - J_{\nu,\pi}(\nu)}{2} \right]^2, \] (12)

and

\[ C^{(0)}(\gamma,\nu) = C_{\pi}^{(0)}(\gamma,\nu) + C_{\sigma}^{(0)}(\gamma,\nu), \]

\[ = -2\pi \alpha N^2 \frac{\Delta \omega}{\omega_0(\gamma,0)} \frac{1}{e + \frac{K^2}{2} \nu} \int_{0}^{\infty} S_n(\mu) \frac{2}{e + \frac{K^2}{2} \nu} d\mu \frac{d\mu}{d\nu} d\phi, \] (13)

\( J_{\nu}(\nu) \) is Auger function. Because both \( H \) and \( C \) are slow functions of \( \nu \), the spectral derivative is dominated by the sinc function \( S_n(\nu) \), with its peak at the nominal harmonic energies. This feature can be clearly seen in Fig. 1.

\[ F^{(0)}(\gamma,\nu) = \frac{1}{\sqrt{2\pi \sigma_\nu^2}} e^{-\frac{\nu^2}{2\sigma_\nu^2}}, \] (14)

where the relative momentum change is defined as \( \delta = \Delta E/E_0 = \Delta \gamma/\gamma_0 \), and \( E_0 \) is the centroid energy. Using the new variables defined in Eq. (7) and the following

\[ \nu_0 = \frac{\nu}{\omega_0(\gamma_0,0)}, \] (15)

we have \( \nu = \nu_0(1 - 2\delta) \). Convolution of Eq. (15) and (6) leads to the angle-integrated photon flux. After dropping higher orders of \( \delta \), we obtain the derivative of the spectrum in the form of a convolution integral,

\[ D_{\pi,\sigma}(\gamma_0,\nu_0) = \frac{1}{\sqrt{2\pi \sigma_\delta^2}} \int e^{-\frac{\delta^2}{2\sigma_\delta^2}} D_{\pi,\sigma}^{(0)}(\gamma_0, n(1 + \delta_\omega - 2\delta)) d\delta, \] (16)

where \( \delta_\omega = \Delta \omega/\omega_0 = n\Delta \nu \) is the relative photon energy deviation.

### 3 BEAM ENERGY MEASUREMENTS

Figure 2 shows the schematics of an experimental setup for measuring angle-integrated flux spectrum. A rotating crystal selects the x-ray energy according to Bragg’s law, \( \lambda = 2d \sin \theta \), where \( \theta \) is the incidence angle of the x-ray beam. The reflected x-rays are collected by an integrating detector. The relative photon energy change is given by \( \Delta \omega/\omega_0 = -\Delta \lambda/\lambda_0 = -\Delta \theta/\tan \theta_0 \), where \( \theta_0 \) is the angle at the center of the flux jump. Converting it to the equivalent electron energy deviation, we have

\[ \frac{\Delta \gamma}{\gamma_0} = \frac{\Delta \omega}{2\omega_0} = \frac{-\Delta \theta}{2\tan \theta_0}. \] (17)

The experimentally measured flux curve, \( F(\theta) \), can be differentiated numerically to obtain the scaled spectral derivative.

![Figure 1: Calculated derivative spectra for the APS diagnostics undulator (N=198). All spectra were normalized to have the same maximum value. The dotted line is for K = 0.01, the dashed line for K = 0.1, the dash-dot line for K = 0.5, and the long-dashed line for K = 1.0. The solid line (top) is the sinc function. Its center peak has an rms width of 0.36/nN.](image)

**Figure 1:** Calculated derivative spectra for the APS diagnostics undulator (N=198). All spectra were normalized to have the same maximum value. The dotted line is for K = 0.01, the dashed line for K = 0.1, the dash-dot line for K = 0.5, and the long-dashed line for K = 1.0. The solid line (top) is the sinc function. Its center peak has an rms width of 0.36/nN.

### 2.3 Electron Beam With Finite Energy Spread

Let us consider electron beams with Gaussian energy distribution,

\[ \rho(\delta) = \frac{1}{\sqrt{2\pi \sigma_\delta^2}} e^{-\frac{\delta^2}{2\sigma_\delta^2}}, \] (14)

3.1 Electron Beam Energy Spread Measurement

The width obtained in fitting the experimentally measured spectral derivative to a Gaussian peak is a sum,

\[ \sigma_{\text{exp}}^2 = \sigma_\delta^2 + \sigma_{\text{res}}^2. \] (18)

where the total resolution is the sum of contributions from various sources

\[ \sigma_{\text{res}}^2 = \sigma_{\text{nd}}^2 + \sigma_{\delta_b}^2 + \sigma_{\text{exp}}^2 + \sigma_{\text{det}}^2 + \sigma_{\text{amp}}^2. \] (19)

Table 1 explains the meaning of these terms and lists their typical values at the APS storage ring. The ideal resolution dominates in the case of the APS undulator. It is also significant that the electron beam size has no impact on the energy measurement.
The contribution of the undulator field error is difficult to express in closed forms. For nearly perfect undulators, the trajectory error does not affect the angle-integrated spectrum to the first order, so we estimate,

\[ \sigma_{\Delta\theta} = \frac{0.18}{nN} \sigma_{\Delta\theta} = \frac{0.18}{N} \sigma_{\Delta} , \]

where \( \sigma_{\Delta} \) and \( \sigma_{\Delta\theta} \) are the rms phase errors of the fundamental and \( n \)-th harmonic.

<table>
<thead>
<tr>
<th>Expression</th>
<th>Source</th>
<th>Typical* values (10^-6)</th>
</tr>
</thead>
<tbody>
<tr>
<td>( \sigma_{\text{und}} = \frac{0.18}{nN} )</td>
<td>Ideal resolution: SINC function central peak</td>
<td>0.9</td>
</tr>
<tr>
<td>( \sigma_{\Delta\theta} = \frac{0.18}{N} \sigma_{\Delta} )</td>
<td>Undulator field error</td>
<td>&lt;0.08</td>
</tr>
<tr>
<td>( \sigma_{\text{rad}} = \frac{\Delta\theta_{\text{rad}}}{6\tan\theta} )</td>
<td>Darwin width, mosaic angle and thermal distortion of the crystal</td>
<td>&lt;0.06</td>
</tr>
<tr>
<td>( \sigma_{\text{div}} = \frac{\sigma_{\text{y}}}{2\tan\theta} )</td>
<td>Beam divergence / angular motion</td>
<td>&lt;0.1 (( y )) &lt;0.02 (( y' ))</td>
</tr>
</tbody>
</table>

* We assume \( nN = 200, \theta_{\text{Si}(200)} = 7.21^\circ, \sigma_{\Delta} < 5^\circ, \Delta\theta_{\text{und}} < 10 \text{ arc-sec}, \sigma_{\Delta\theta} < 25 \text{ microrad}, \) and \( \sigma_{\Delta} < 5 \text{ microrad}. 

### 3.2 Absolute Electron Beam Energy Measurement

Equation (11) indicates that the spectral derivative peaks very nearly at the nominal harmonic energy. This can be used to estimate the beam energy with the center angle obtained in fitting the experimentally measured spectral derivative, \( \theta_{\text{cen}} \).

\[ \gamma = \frac{\lambda}{4d \sin\theta_{\text{cen}}} \left( 1 + \frac{K^2}{2} \right) . \]

The error in the beam energy can therefore be given by

\[ \left( \frac{\Delta\gamma}{\gamma} \right)^2 = \left( \frac{\Delta\lambda}{\lambda_{\text{cen}}} \right)^2 + \left( \frac{\Delta K}{K} \right)^2 + \left( \frac{\Delta d}{d} \right)^2 + \left( \frac{\Delta \theta_{\text{cen}}}{\theta_{\text{cen}}} \right)^2 . \]

The errors from the undulator can be minimized when running at low power (\( K \)). Errors from the monochromator crystal can be minimized when a silicon crystal is used at cryogenic temperatures [4]. The difficulty of measuring the absolute value of the angle \( \theta \) can be overcome by scanning the monochromator through spectral peaks at both negative and positive angles and taking the difference as \( 2\theta_{\text{cen}} \) (Fig. 3). Table 2 lists the typical values at the APS storage ring. Under these conditions, an accuracy of \( 10^{-5} \) can be obtained for the absolute energy measurement.

Turn-by-turn energy measurements can be performed when flux at four crystal angles (\( \theta_{\text{cen}} \), though \( \theta_{\text{cen}} \) in Fig. 3) is obtained simultaneously with Laue crystal arrays.

### 4 CONCLUSION

We proposed to use the angle-integrated undulator spectra to measure the centroid and rms spread of the electron beam energy. The advantages of this new technique are: (1) its calibration is independent of the ring lattice parameter, (2) it is not sensitive to the beam emittance and other lattice parameters, and (3) a fast turn-by-turn measurement is feasible.

### 5 REFERENCES


